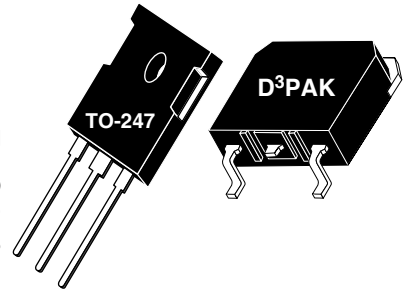
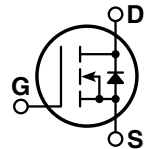


## POWER MOS 7<sup>®</sup> FREDFET

Power MOS 7<sup>®</sup> is a new generation of low loss, high voltage, N-Channel enhancement mode power MOSFETS. Both conduction and switching losses are addressed with Power MOS 7<sup>®</sup> by significantly lowering  $R_{DS(on)}$  and  $Q_g$ . Power MOS 7<sup>®</sup> combines lower conduction and switching losses along with exceptionally fast switching speeds inherent with Microsemi's patented metal gate structure.



- Lower Input Capacitance
- Lower Miller Capacitance
- Lower Gate Charge,  $Q_g$
- Increased Power Dissipation
- Easier To Drive
- TO-247 or Surface Mount D<sup>3</sup>PAK Package



### MAXIMUM RATINGS

All Ratings:  $T_C = 25^\circ\text{C}$  unless otherwise specified.

| Symbol         | Parameter                                                      | APT1201R4B_SFL | UNIT                |
|----------------|----------------------------------------------------------------|----------------|---------------------|
| $V_{DSS}$      | Drain-Source Voltage                                           | 1200           | Volts               |
| $I_D$          | Continuous Drain Current @ $T_C = 25^\circ\text{C}$            | 9              | Amps                |
| $I_{DM}$       | Pulsed Drain Current <sup>①</sup>                              | 36             |                     |
| $V_{GS}$       | Gate-Source Voltage Continuous                                 | $\pm 30$       | Volts               |
| $V_{GSM}$      | Gate-Source Voltage Transient                                  | $\pm 40$       |                     |
| $P_D$          | Total Power Dissipation @ $T_C = 25^\circ\text{C}$             | 300            | Watts               |
|                | Linear Derating Factor                                         | 2.40           | W/ $^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range               | -55 to 150     | $^\circ\text{C}$    |
| $T_L$          | Lead Temperature: 0.063" from Case for 10 Sec.                 | 300            |                     |
| $I_{AR}$       | Avalanche Current <sup>①</sup> (Repetitive and Non-Repetitive) | 9              | Amps                |
| $E_{AR}$       | Repetitive Avalanche Energy <sup>①</sup>                       | 30             | mJ                  |
| $E_{AS}$       | Single Pulse Avalanche Energy <sup>④</sup>                     | 1210           |                     |

### STATIC ELECTRICAL CHARACTERISTICS

| Symbol       | Characteristic / Test Conditions                                                          | MIN  | TYP | MAX       | UNIT    |
|--------------|-------------------------------------------------------------------------------------------|------|-----|-----------|---------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage ( $V_{GS} = 0V, I_D = 250\mu A$ )                          | 1200 |     |           | Volts   |
| $R_{DS(on)}$ | Drain-Source On-State Resistance <sup>②</sup> ( $V_{GS} = 10V, I_D = 4.5A$ )              |      |     | 1.50      | Ohms    |
| $I_{DSS}$    | Zero Gate Voltage Drain Current ( $V_{DS} = 1200V, V_{GS} = 0V$ )                         |      |     | 250       | $\mu A$ |
|              | Zero Gate Voltage Drain Current ( $V_{DS} = 960V, V_{GS} = 0V, T_C = 125^\circ\text{C}$ ) |      |     | 1000      |         |
| $I_{GSS}$    | Gate-Source Leakage Current ( $V_{GS} = \pm 30V, V_{DS} = 0V$ )                           |      |     | $\pm 100$ | nA      |
| $V_{GS(th)}$ | Gate Threshold Voltage ( $V_{DS} = V_{GS}, I_D = 1mA$ )                                   | 3    |     | 5         | Volts   |



**CAUTION:** These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

# DYNAMIC CHARACTERISTICS

APT1201R4B\_SFL

| Symbol       | Characteristic               | Test Conditions                                                                                                 | MIN | TYP  | MAX | UNIT |
|--------------|------------------------------|-----------------------------------------------------------------------------------------------------------------|-----|------|-----|------|
| $C_{iss}$    | Input Capacitance            | $V_{GS} = 0V$<br>$V_{DS} = 25V$<br>$f = 1 \text{ MHz}$                                                          |     | 2030 |     | pF   |
| $C_{oss}$    | Output Capacitance           |                                                                                                                 |     | 310  |     |      |
| $C_{rss}$    | Reverse Transfer Capacitance |                                                                                                                 |     | 60   |     |      |
| $Q_g$        | Total Gate Charge ③          | $V_{GS} = 10V$<br>$V_{DD} = 600V$<br>$I_D = 9A @ 25^\circ C$                                                    |     | 75   |     | nC   |
| $Q_{gs}$     | Gate-Source Charge           |                                                                                                                 |     | 10   |     |      |
| $Q_{gd}$     | Gate-Drain ("Miller") Charge |                                                                                                                 |     | 50   |     |      |
| $t_{d(on)}$  | Turn-on Delay Time           | <b>RESISTIVE SWITCHING</b><br>$V_{GS} = 15V$<br>$V_{DD} = 600V$<br>$I_D = 9A @ 25^\circ C$<br>$R_G = 1.6\Omega$ |     | 8    |     | ns   |
| $t_r$        | Rise Time                    |                                                                                                                 |     | 5    |     |      |
| $t_{d(off)}$ | Turn-off Delay Time          |                                                                                                                 |     | 27   |     |      |
| $t_f$        | Fall Time                    |                                                                                                                 |     | 11   |     |      |
| $E_{on}$     | Turn-on Switching Energy ⑥   | <b>INDUCTIVE SWITCHING @ 25°C</b><br>$V_{DD} = 800V, V_{GS} = 15V$<br>$I_D = 9A, R_G = 5\Omega$                 |     | 500  |     | μJ   |
| $E_{off}$    | Turn-off Switching Energy    |                                                                                                                 |     | XX   |     |      |
| $E_{on}$     | Turn-on Switching Energy ⑥   | <b>INDUCTIVE SWITCHING @ 125°C</b><br>$V_{DD} = 800V, V_{GS} = 15V$<br>$I_D = 9A, R_G = 4.3\Omega$              |     | 545  |     |      |
| $E_{off}$    | Turn-off Switching Energy    |                                                                                                                 |     | 18   |     |      |

# SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

| Symbol    | Characteristic / Test Conditions                                   | MIN                 | TYP | MAX | UNIT  |
|-----------|--------------------------------------------------------------------|---------------------|-----|-----|-------|
| $I_S$     | Continuous Source Current (Body Diode)                             |                     |     | 9   | Amps  |
| $I_{SM}$  | Pulsed Source Current ① (Body Diode)                               |                     |     | 36  |       |
| $V_{SD}$  | Diode Forward Voltage ② ( $V_{GS} = 0V, I_S = -I_D 9A$ )           |                     |     | 1.3 | Volts |
| $dv/dt$   | Peak Diode Recovery $dv/dt$ ⑤                                      |                     |     | 18  | V/ns  |
| $t_{rr}$  | Reverse Recovery Time<br>( $I_S = -I_D 9A, di/dt = 100A/\mu s$ )   | $T_J = 25^\circ C$  |     | 210 | ns    |
|           |                                                                    | $T_J = 125^\circ C$ |     | 710 |       |
| $Q_{rr}$  | Reverse Recovery Charge<br>( $I_S = -I_D 9A, di/dt = 100A/\mu s$ ) | $T_J = 25^\circ C$  | 0.7 |     | μC    |
|           |                                                                    | $T_J = 125^\circ C$ | 2.0 |     |       |
| $I_{RRM}$ | Peak Recovery Current<br>( $I_S = -I_D 9A, di/dt = 100A/\mu s$ )   | $T_J = 25^\circ C$  | 10  |     | Amps  |
|           |                                                                    | $T_J = 125^\circ C$ | 15  |     |       |

# THERMAL CHARACTERISTICS

| Symbol          | Characteristic      | MIN | TYP | MAX  | UNIT |
|-----------------|---------------------|-----|-----|------|------|
| $R_{\theta JC}$ | Junction to Case    |     |     | 0.42 | °C/W |
| $R_{\theta JA}$ | Junction to Ambient |     |     | 40   |      |

① Repetitive Rating: Pulse width limited by maximum junction temperature

② Pulse Test: Pulse width < 380 μs, Duty Cycle < 2%

③ See MIL-STD-750 Method 3471

④ Starting  $T_J = +25^\circ C$ ,  $L = 29.9mH$ ,  $R_G = 25\Omega$ , Peak  $I_L = 9A$

⑤  $dv/dt$  numbers reflect the limitations of the test circuit rather than the device itself.  $I_S \leq -I_D 9A$   $di/dt \leq 700A/\mu s$   $V_R \leq 1200$   $T_J \leq 150^\circ C$

⑥  $E_{on}$  includes diode reverse recovery. See figures 18, 20.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

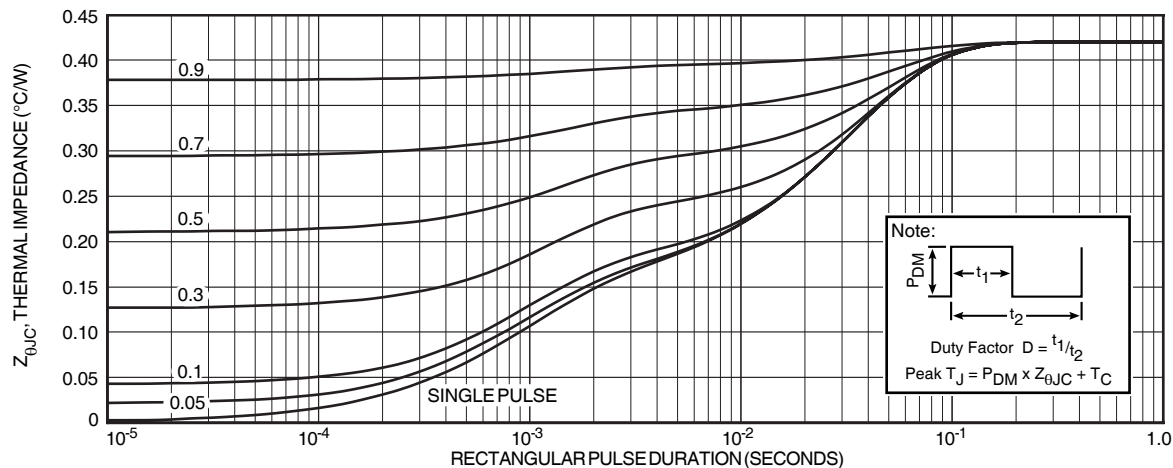


FIGURE 1, MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

# Typical Performance Curves

APT1201R4B\_SFL

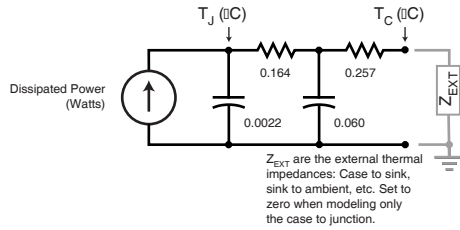


FIGURE 2, TRANSIENT THERMAL IMPEDANCE MODEL

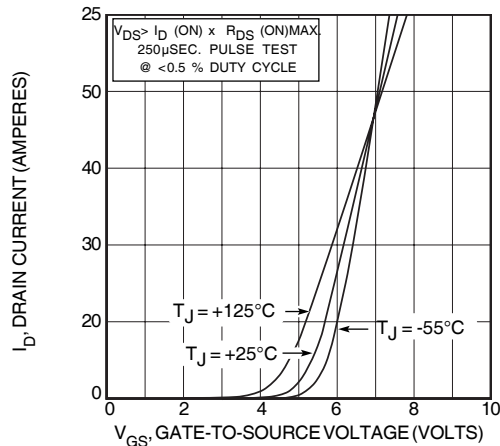


FIGURE 4, TRANSFER CHARACTERISTICS

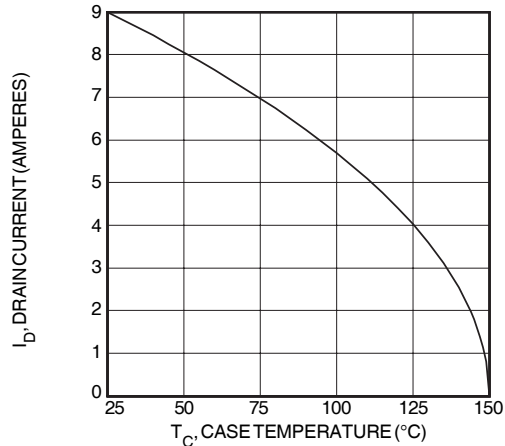


FIGURE 6, MAXIMUM DRAIN CURRENT vs CASE TEMPERATURE

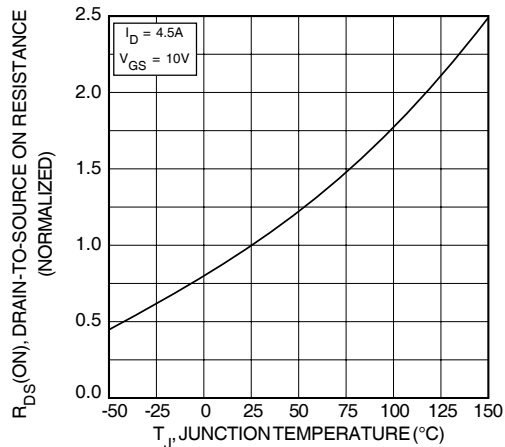


FIGURE 8, ON-RESISTANCE vs. TEMPERATURE

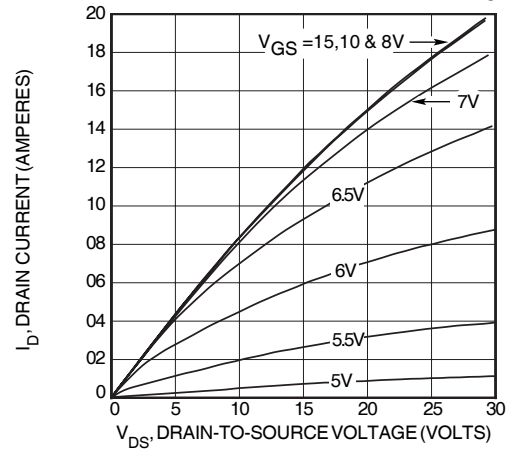


FIGURE 3, LOW VOLTAGE OUTPUT CHARACTERISTICS

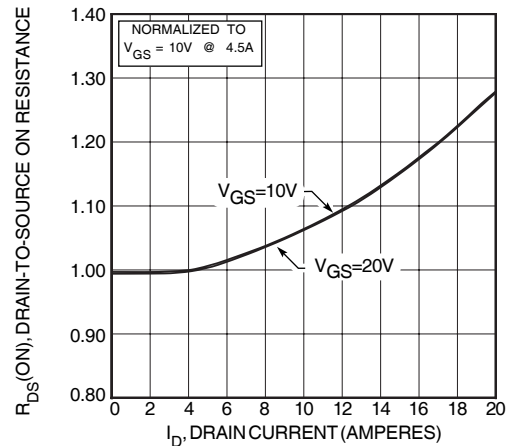


FIGURE 5,  $R_{DS(ON)}$  vs DRAIN CURRENT

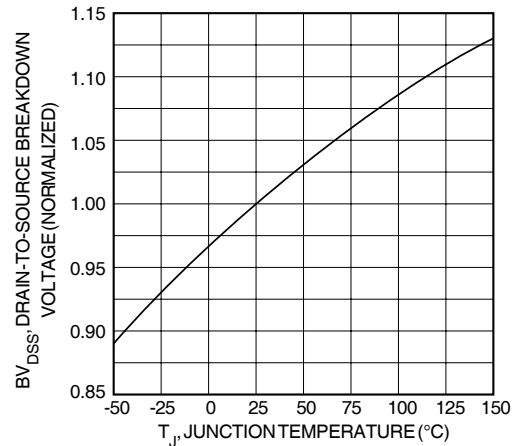


FIGURE 7, BREAKDOWN VOLTAGE vs TEMPERATURE

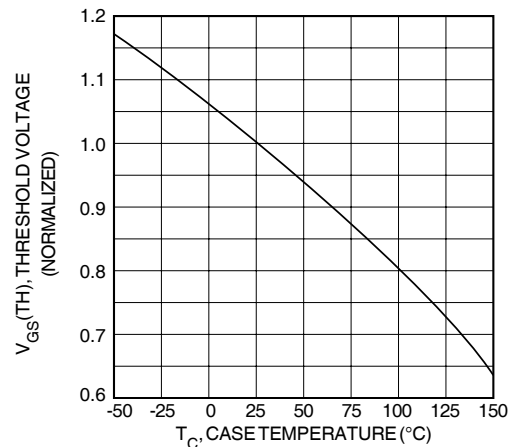


FIGURE 9, THRESHOLD VOLTAGE vs TEMPERATURE

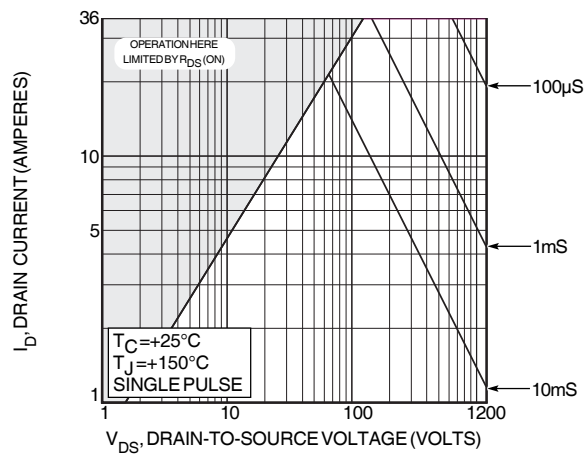


FIGURE 10, MAXIMUM SAFE OPERATING AREA

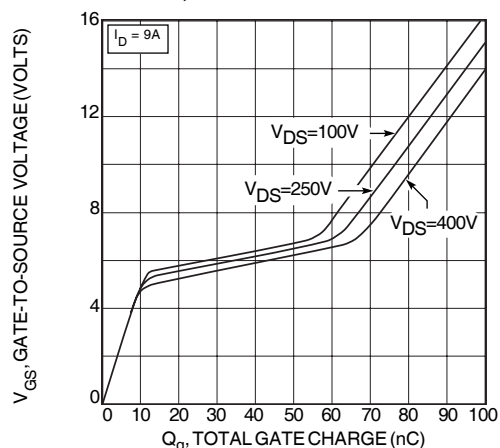


FIGURE 12, GATE CHARGES vs GATE-TO-SOURCE VOLTAGE

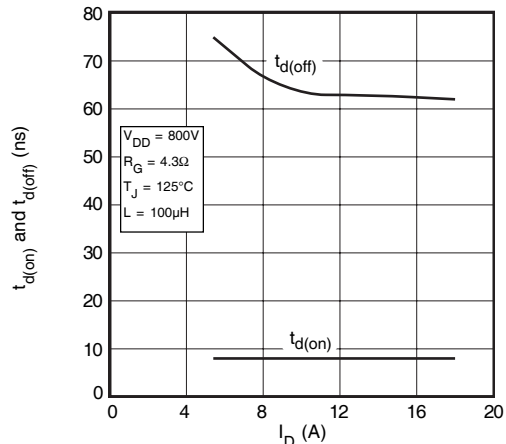


FIGURE 14, DELAY TIMES vs CURRENT

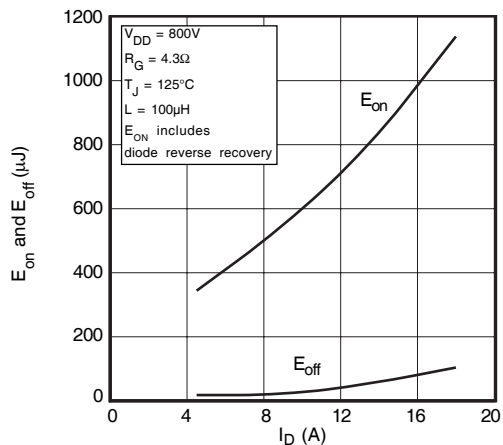


FIGURE 16, SWITCHING ENERGY vs CURRENT

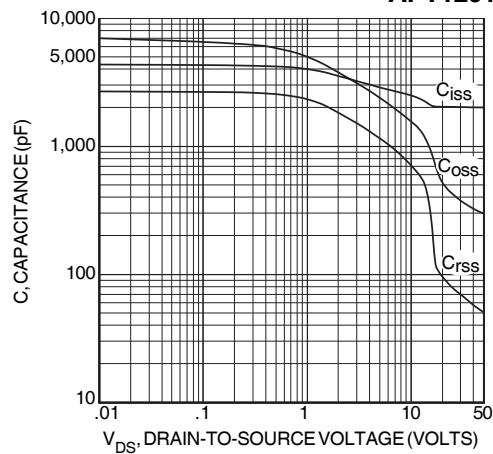


FIGURE 11, CAPACITANCE vs DRAIN-TO-SOURCE VOLTAGE

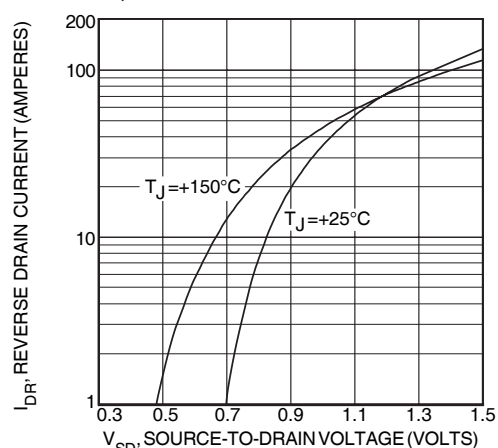


FIGURE 13, SOURCE-DRAIN DIODE FORWARD VOLTAGE

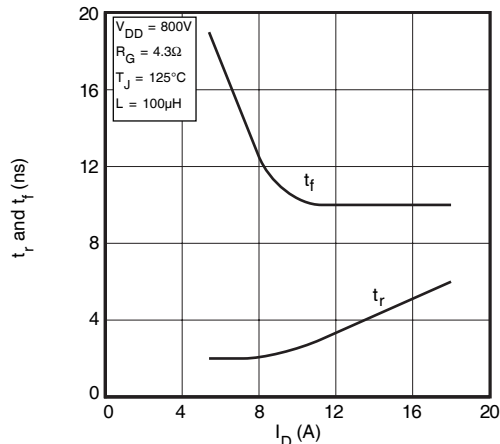


FIGURE 15, RISE AND FALL TIMES vs CURRENT

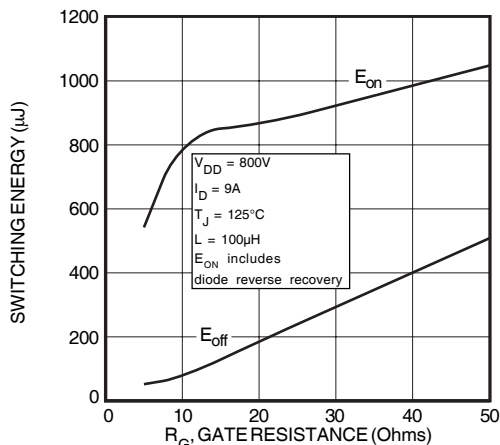


FIGURE 17, SWITCHING ENERGY vs. GATE RESISTANCE

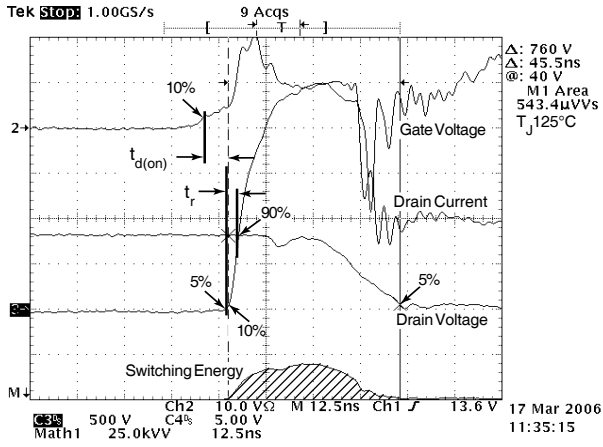


Figure 18, Turn-on Switching Waveforms and Definitions

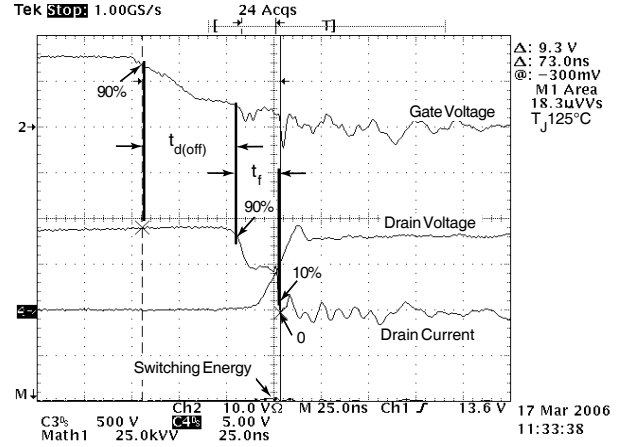


Figure 19, Turn-off Switching Waveforms and Definitions

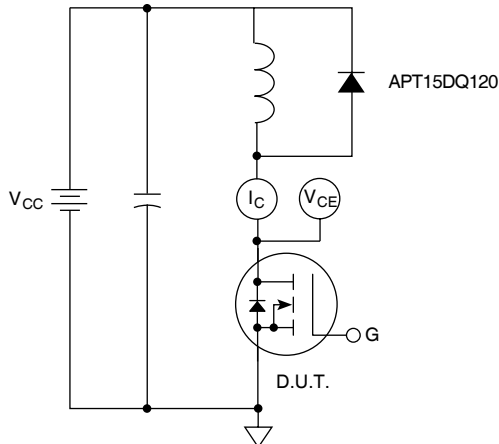
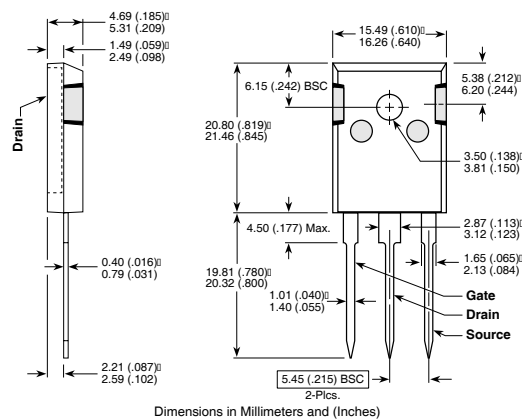
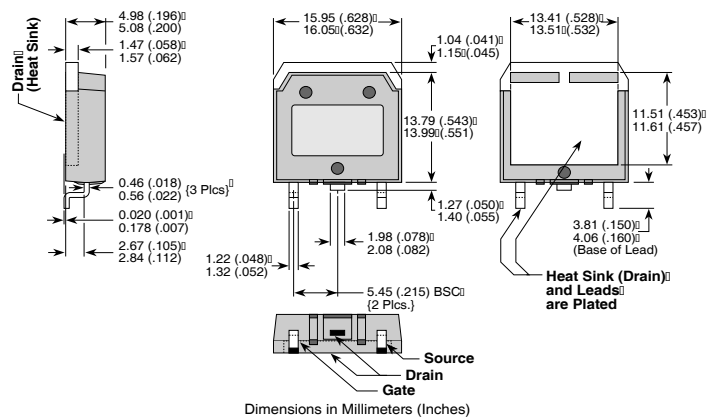


Figure 20, Inductive Switching Test Circuit

## TO-247 Package Outline



## D<sup>3</sup>PAK Package Outline



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